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Ignition IGBT 20 A, 365 V, N–Channel D²PAK

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Overvoltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

Features

- Ideal for Coil-on-Plug and Driver-on-Coil Applications
- Gate-Emitter ESD Protection
- Temperature Compensated Gate–Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- Low Threshold Voltage for Interfacing Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Minimum Avalanche Energy 500 mJ
- Gate Resistor (R_G) = 70 Ω
- This is a Pb-Free Device

Applications

• Ignition Systems

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating Symbol Value L							
Rating	Symbol	value	Unit				
Collector-Emitter Voltage	V _{CES}	365	V				
Gate-Emitter Voltage	V_{GE}	±15	V				
Collector Current–Continuous @ $T_C = 25^{\circ}C$ – Pulsed	Ι _C	20 50	A _{DC} A _{AC}				
Continuous Gate Current	I _G	1.0	mA				
Transient Gate Current (t \leq 2 ms, f \leq 100 Hz)	I _G	20	mA				
ESD (Charged-Device Model)	ESD	2.0	kV				
ESD (Human Body Model) R = 1500 Ω , C = 100 pF	ESD	8.0	kV				
ESD (Machine Model) R = 0 Ω , C = 200 pF	ESD	500	V				
Total Power Dissipation @ T _C = 25°C Derate above 25°C (Note 1)	P _D	165 1.1	W W/°C				
Operating & Storage Temperature Range	T _J , T _{stg}	–55 to +175	°C				

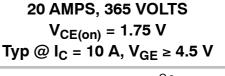
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

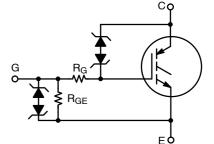
1. Assuming infinite heatsink Case-to-Ambient



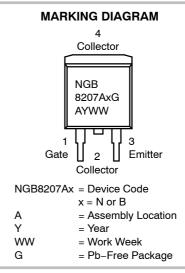
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ORDERING INFORMATION

Device	Package	Shipping [†]
NGB8207ANT4G	D ² PAK (Pb–Free)	800 / Tape & Reel
NGB8207ABNT4G	D ² PAK (Pb-Free)	800 / Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

UNCLAMPED COLLECTOR-TO-EMITTER AVALANCHE CHARACTERISTICS (-40° $\leq T_{\rm J} \leq 150^{\circ} C)$

Characteristic	Symbol	Value	Unit
Single Pulse Collector–to–Emitter Avalanche Energy $V_{CC} = 50 \text{ V}, \text{ V}_{GE} = 10 \text{ V}, \text{ Pk } \text{ I}_{L} = 16.5 \text{ A}, \text{ L} = 3.7 \text{ mH}, \text{ R}_{g} = 1 \text{k}\Omega \text{ Starting } \text{T}_{J} = 25^{\circ}\text{C}$ $V_{CC} = 50 \text{ V}, \text{ V}_{GE} = 10 \text{ V}, \text{ Pk } \text{ I}_{L} = 10 \text{ A}, \text{ L} = 6.1 \text{ mH}, \text{ R}_{g} = 1 \text{k}\Omega \text{ Starting } \text{T}_{J} = 125^{\circ}\text{C}$	E _{AS}	500 306	mJ
Reverse Avalanche Energy V _{CC} = 100 V, V _{GE} = 20 V, Pk I _L = 25.8 A, L = 6.0 mH, Starting T _J = 25°C	E _{AS(R)}	2000	mJ

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case	$R_{ hetaJC}$	0.9	°C/W
Thermal Resistance, Junction-to-Ambient (Note 2)	R_{\thetaJA}	50	°C/W
Maximum Temperature for Soldering Purposes, 0.125 in from case for 5 seconds (Note 3)	ΤL	275	°C

When surface mounted to an FR4 board using the minimum recommended pad size.
For further details, see Soldering and Mounting Techniques Reference Manual: SOLDERRM/D.

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•	•				
Collector-Emitter Clamp Voltage	BV _{CES}	I _C = 2.0 mA	$T_J = -40^{\circ}C$ to $150^{\circ}C$	325	350	375	V
		I _C = 10 mA	$T_J = -40^{\circ}C$ to $150^{\circ}C$	340	365	390	
Zero Gate Voltage Collector Current	I _{CES}	V _{CE} = 24 V V _{GE} = 0 V	$T_J = 25^{\circ}C$		0.1	2.0	μΑ
			$T_J = 25^{\circ}C$	-	1.0	5	
		V _{CE} = 250 V V _{GE} = 0 V	T _J = 150°C	-	10	125	
			$T_{\rm J} = -40^{\circ}C$	-	0.25	2.5	
Reverse Collector-Emitter Clamp Voltage	B _{VCES(R)}		$T_J = 25^{\circ}C$	25	27	29	V
		I _C = -75 mA	T _J = 150°C	25	29	31	
			$T_J = -40^{\circ}C$	24	26	29	
Reverse Collector-Emitter Leakage Current	I _{CES(R)}		$T_J = 25^{\circ}C$	-	0.5	1.1	mA
		V _{CE} = -24 V	$T_J = 150^{\circ}C$	20	25	40	
			$T_J = -40^{\circ}C$	-	0.03	1.0	
Gate-Emitter Clamp Voltage	BV _{GES}	$I_{G} = \pm 5.0 \text{ mA}$	$T_J = -40^{\circ}C$ to $150^{\circ}C$	12	13	14.5	V
Gate-Emitter Leakage Current	I _{GES}	$V_{GE} = \pm 10 \text{ V}$	$T_J = -40^{\circ}C$ to $150^{\circ}C$	500	700	1000	μΑ
Gate Resistor	R _G		$T_J = -40^{\circ}C$ to $150^{\circ}C$		70		Ω
Gate-Emitter Resistor	R _{GE}		$T_J = -40^{\circ}C$ to $150^{\circ}C$	14.25	16	25	kΩ

ON CHARACTERISTICS (Note 4)

Gate Threshold Voltage	V _{GE(th)}		$T_J = 25^{\circ}C$	1.2	1.5	2.0	V
		I _C = 1.0 mA V _{GE} = V _{CE}	T _J = 150°C	0.7	1.0	1.3	1
		•GE - •CE	$T_{\rm J} = -40^{\circ} C$	1.4	1.7	2.0	
Threshold Temperature Coefficient (Negative)				-	4.0	-	mV/°C
Collector-to-Emitter On-Voltage	V _{CE(on)}	$V_{CE(on)}$ $I_C = 6.0 \text{ A}$ $V_{GE} = 4.0 \text{ V}$	$T_J = 25^{\circ}C$	1.15	1.5	1.75	V
			$T_J = 150^{\circ}C$	1.2	1.4	1.75	
			$T_J = -40^{\circ}C$	1.2	1.6	1.75	
		I _C = 10 mA V _{GE} = 4.5 V	T _J = 25°C	-	0.62	1.0	

*Maximum Value of Characteristic across Temperature Range.

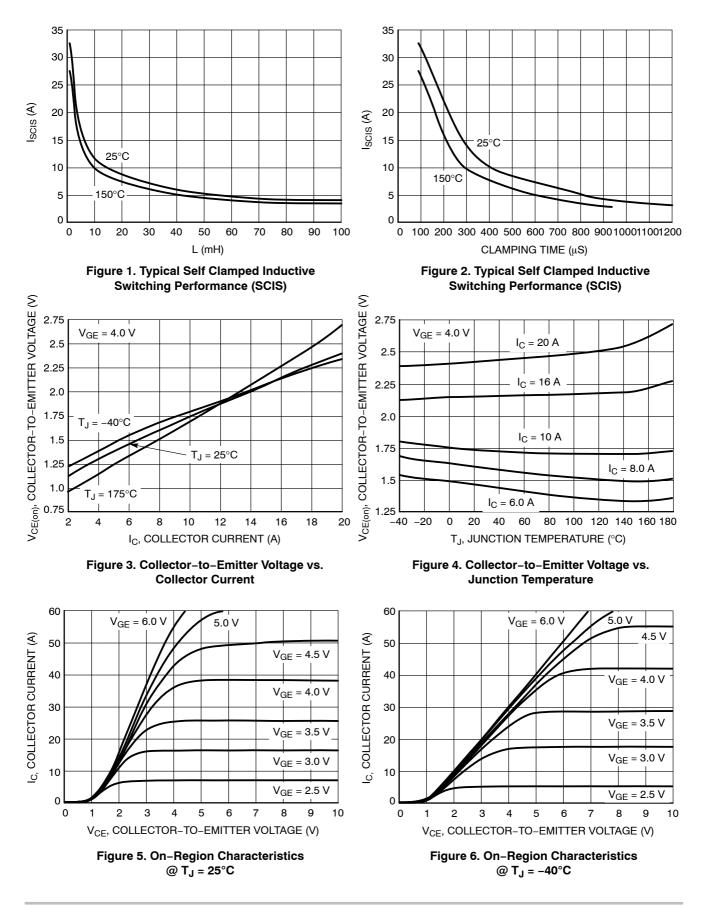
4. Pulse Test: Pulse Width \leq 300 μ S, Duty Cycle \leq 2%.

ELECTRICAL CHARACTERISTICS

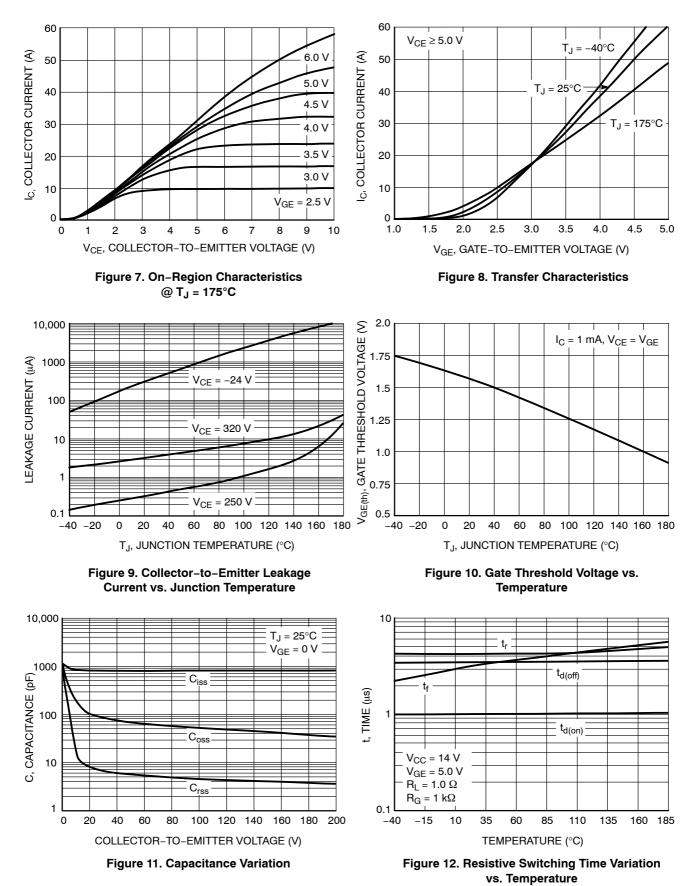
Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
ON CHARACTERISTICS (Note 4)	<u>.</u>				-	-	
Collector-to-Emitter On-Voltage	V _{CE(on)}		$T_J = 25^{\circ}C$	1.2	1.65	2.0	V
		I _C = 8.0 A V _{GE} = 4.0 V	$T_J = 150^{\circ}C$	1.4	1.6	2.0	
		GE	$T_J = -40^{\circ}C$	1.4	1.7	2.0	
			$T_J = 25^{\circ}C$	1.35	1.8	2.2	
		I _C = 10 A V _{GE} = 3.7 V	$T_{J} = 150^{\circ}C$	1.5	1.9	2.2	
		GL	$T_J = -40^{\circ}C$	1.5	1.85	2.2	
			$T_J = 25^{\circ}C$	1.35	1.8	2.1	
		I _C = 10 A V _{GE} = 4.0 V	$T_{\rm J} = 150^{\circ}C$	1.5	1.8	2.1	
		GL	$T_J = -40^{\circ}C$	1.5	1.8	2.1	
		I _C = 10 A V _{GE} = 4.5 V	$T_J = 25^{\circ}C$	1.35	1.75	2.05	
			$T_{\rm J} = 150^{\circ}C$	1.4	1.75	2.1	
			$T_J = -40^{\circ}C$	1.4	1.8	2.1	
Forward Transconductance	gfs	I _C = 6.0 A V _{CE} = 5.0 V	$T_J = 25^{\circ}C$	-	15.8	-	Mhos
DYNAMIC CHARACTERISTICS	•						
Input Capacitance	C _{ISS}			750	810	900	pF
Output Capacitance	C _{OSS}	f = 10 kHz V _{CF} = 25 V	$T_J = 25^{\circ}C$	75	90	105	
Transfer Capacitance	C _{RSS}			4	7	12	
SWITCHING CHARACTERISTICS							
Turn-On Delay Time (Resistive) Low Voltage	t _{d(on)}	V _{CE} = 14 V R _L = 1.0 Ω	$T_J = 25^{\circ}C$	0.5	0.55	0.7	μSec
Rise Time (Resistive) Low Voltage	t _r	V _{GE} = 5.0 V R _G = 1000 Ω	$T_J = 25^{\circ}C$	2.0	2.32	2.7	
Turn-Off Delay Time (Resistive) Low Voltage	t _{d(off)}	V _{CE} = 14 V R _L = 1.0 Ω	$T_J = 25^{\circ}C$	2.0	2.5	3.0	
Fall Time (Resistive) Low Voltage	t _f	V _{GE} = 5.0 V R _G = 1000 Ω	$T_J = 25^{\circ}C$	8.0	10	13	
Turn-On Delay Time (Resistive) High Voltage	t _{d(on)}	V _{CE} = 300 V R _L = 46 Ω	$T_J = 25^{\circ}C$	0.5	0.65	0.75	
Rise Time (Resistive) High Voltage	t _r	V _{GE} = 5.0 V R _G = 1000 Ω	$T_J = 25^{\circ}C$	0.7	1.8	2.0	
Turn-Off Delay Time (Resistive) High Voltage	t _{d(off)}	$V_{CE} = 300 V$ $R_{L} = 46 \Omega$	$T_J = 25^{\circ}C$	4.0	4.7	6.0	
Fall Time (Resistive) High Voltage	t _f	V _{GE} = 5.0 V R _G = 1000 Ω	$T_J = 25^{\circ}C$	6.0	10	15	

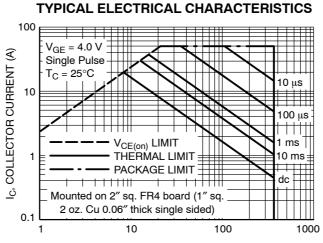
*Maximum Value of Characteristic across Temperature Range. 4. Pulse Test: Pulse Width \leq 300 µS, Duty Cycle \leq 2%.

TYPICAL ELECTRICAL CHARACTERISTICS



TYPICAL ELECTRICAL CHARACTERISTICS





V_{CE}, COLLECTOR-EMITTER VOLTAGE (V)

Figure 13. Forward Biased Safe Operating

Area

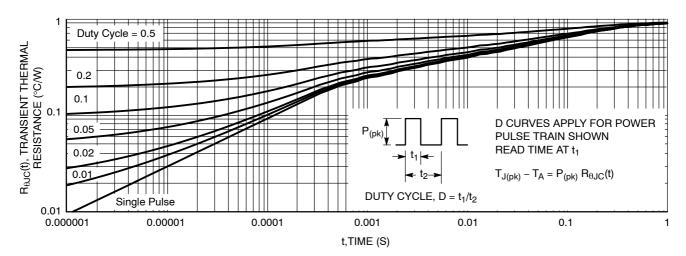
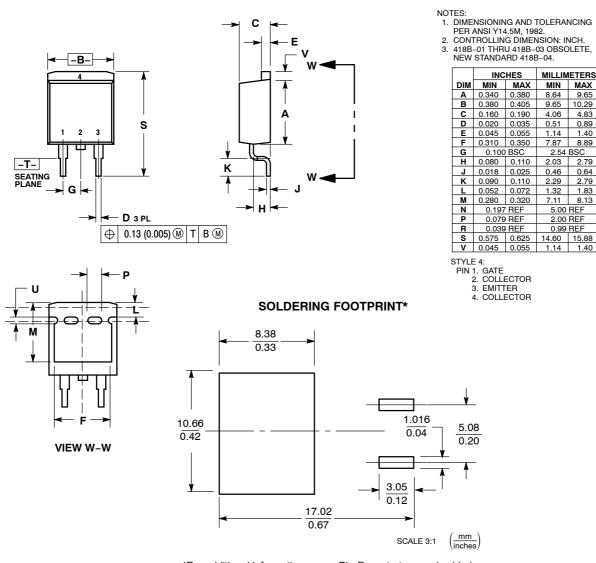


Figure 14. Best Case Transient Thermal Resistance (Non-normalized Junction-to-Case Mounted on Cold Plate)

PACKAGE DIMENSIONS

D²PAK 3 CASE 418B-04 ISSUE J



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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